

October 2013

# **FDP2614**

# N-Channel PowerTrench® MOSFET 200 V, 62 A, 27 m $\Omega$

### **Features**

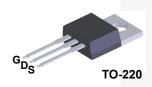
- $R_{DS(on)}$  = 22.9 m $\Omega$  ( Typ.)@  $V_{GS}$  = 10 V,  $I_D$  = 31 A
- · Fast Switching Speed
- · Low Gate Charge
- High Performance Trench technology for Extremely Low  $R_{\mbox{\footnotesize{DS}}(\mbox{\footnotesize{on}})}$
- · High Power and Current Handing Capability
- RoHS Compliant

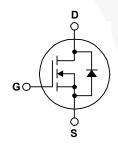
## **General Description**

This N-Channel MOSFET is producedusing Fairchild Semiconductor's advanced PowerTrench® process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

## **Applications**

- Consumer Appliances
- Synchronous Rectification
- · Battery Protection Circuit
- · Motor Drives and Uninterruptible Power Supplies





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol		Parameter		FDP2614	Unit
V <sub>DS</sub>	Drain-Source Voltage		200	V	
V <sub>GS</sub>	Gate-Source Voltage		± 30	V	
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		62 39.3	A A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	see Figure 9	A
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		145	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns	
$P_{D}$	Power Dissipation	ver Dissipation (T <sub>C</sub> = 25°C) - Derate above 25°C		260 2.1	W W/°C
T <sub>J,</sub> T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C	

## **Thermal Characteristics**

Symbol	Parameter	FDP2614	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.48	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	°C/W	

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Package	Reel Size	Tape Width	Quantity
FDP2614	FDP2614	TO-220	Tube	N/A	50 units

# **Electrical Characteristics** $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
Off Charac	Off Characteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0V$ , $I_D = 250\mu A$ , $T_J = 25^{\circ}C$	200			V	
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C		0.2		V/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 200V, V <sub>GS</sub> = 0V V <sub>DS</sub> = 200V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C			10 500	μ <b>Α</b> μ <b>Α</b>	
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30V, V <sub>DS</sub> = 0V			100	nA	
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30V, V <sub>DS</sub> = 0V			-100	nA	
On Charac	teristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0	4.0	5.0	V	
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 31A		22.9	27	mΩ	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10V, I <sub>D</sub> = 31A		72		S	
Dynamic C	Dynamic Characteristics						
C <sub>iss</sub>	Input Capacitance			5435	7230	pF	
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V f = 1.0MHz	\	505	675	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1.5WHZ	\	110	165	pF	
Switching	Switching Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time			77	165	ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 100V, I_{D} = 62A$ $V_{GS} = 10V, R_{GEN} = 25\Omega$		284	560	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time			103	220	ns	
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)		162	335	ns	
Qg	Total Gate Charge			76	99	nC	
Q <sub>gs</sub>	Gate-Source Charge	$V_{DS} = 100V, I_{D} = 62A$ $V_{GS} = 10V$	/	35		nC	
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4)		18		nC	
Drain-Sour	ce Diode Characteristics and Maximur	n Ratings					
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				62	Α	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				186	Α	
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 62A			1.2	V	
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>S</sub> = 62A		145		ns	
Q <sub>rr</sub>	Reverse Recovery Charge	dl <sub>F</sub> /dt =100A/μs		0.81		μС	

#### Notes

<sup>1.</sup> Repetitive Rating: Pulse width limited by maximum junction temperature

<sup>2.</sup> L = 1mH,  $I_{AS}$  = 17A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C

<sup>3.</sup>  $I_{SD} \le 62 \text{A}$ , di/dt  $\le 100 \text{A}/\mu\text{s}$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J$  = 25°C

<sup>4.</sup> Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

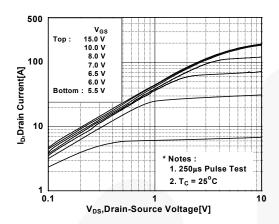
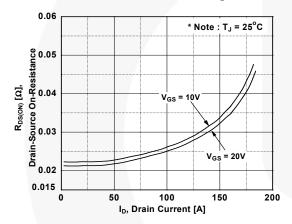


Figure 3. On-Resistance Variation vs. Drain
Current and Gate Voltage



**Figure 5. Capacitance Characteristics** 

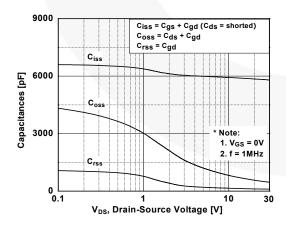


Figure 2. Transfer Characteristics

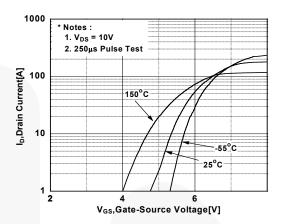


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

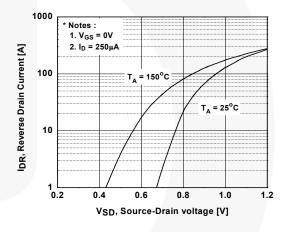
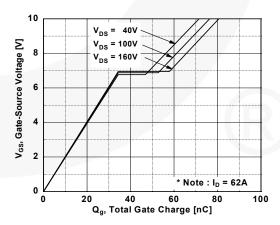


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics (Continued)**

Figure 7. Breakdown Voltage Variation vs.
Temperature

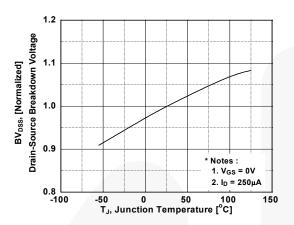
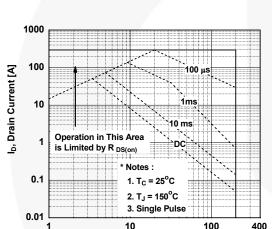


Figure 9. Maximum Safe Operating Area



V<sub>DS</sub>, Drain-Source Voltage [V]

Figure 8. On-Resistance Variation vs. Temperature

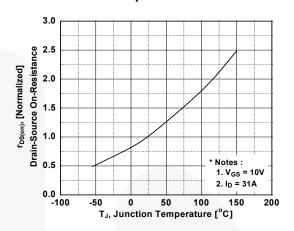


Figure 10. Maximum Drain Current vs. Case-Temperature

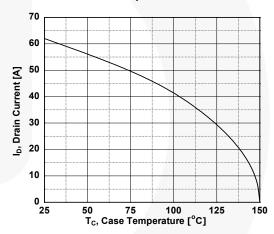


Figure 11. Transient Thermal Response Curve

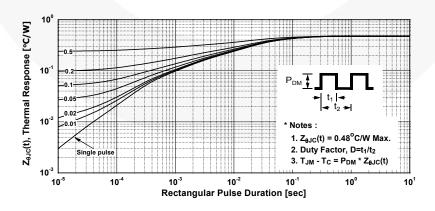


Figure 12. Gate Charge Test Circuit & Waveform

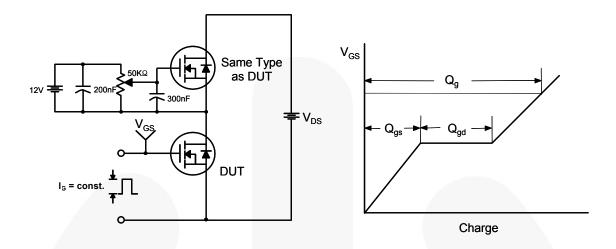


Figure 13. Resistive Switching Test Circuit & Waveforms

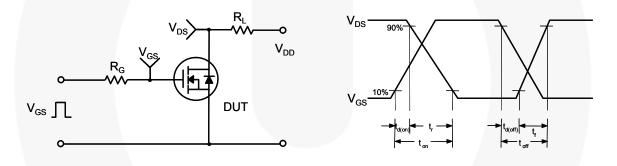
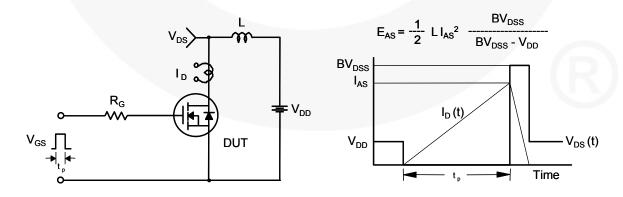
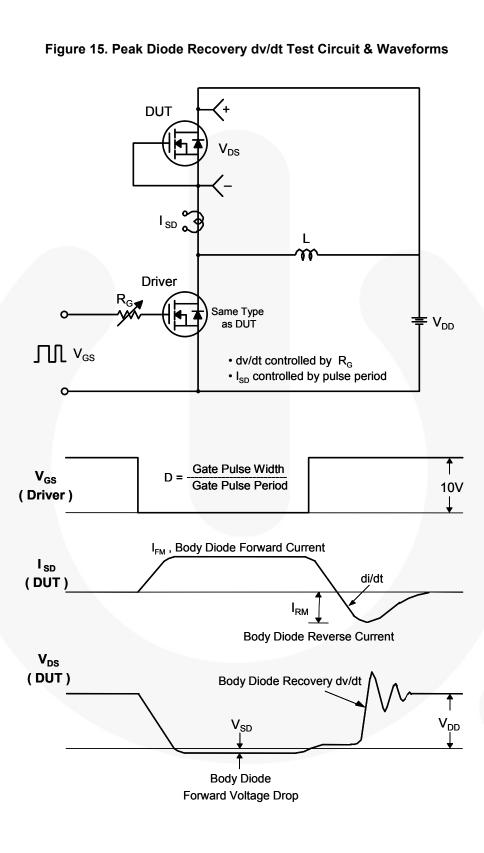


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms





## **Mechanical Dimensions**

# TO-220 3L

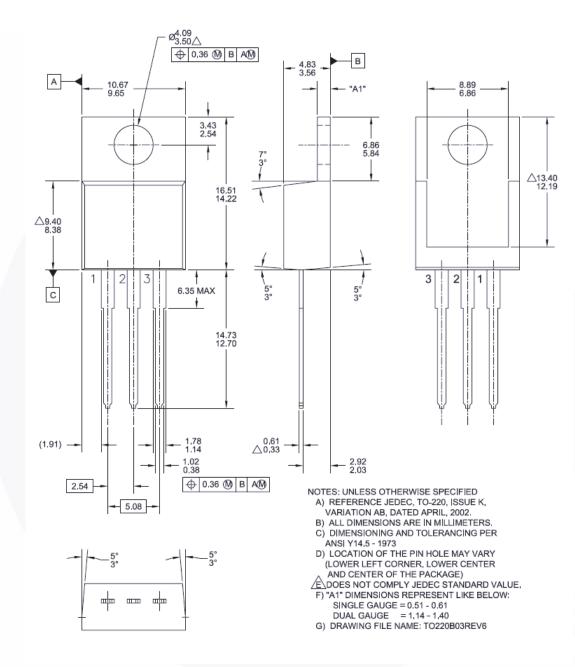


Figure 16. TO-220, Molded, 3Lead, Jedec Variation AB

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Dimension in Millimeters





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